



CSP MOSFET 数据手册

NP15N12B

CSP 12V Typ 5.5mΩ Dual N-Channel MOSFET

Rev 1.0

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最大额定值 Maximum Ratings^①

参数 Parameter	符号 Symbol	数值 Value	单位 Unit
源极-源极击穿电压 Source-Source Breakdown Voltage	BV_{SSS}	12	V
栅极-源极电压 Gate to Source Voltage	V_{GS}	± 8	V
直流源极电流 Source Current (DC)	I_S	8	A
脉冲源电极电流 Source Current (Pulse) $PW \leq 10\mu s, Duty Cycle \leq 1\%$	I_{Sp}	80	A
耗散功率 Power Dissipation	P_D	0.5	W
结温 Operating Junction Temperature	T_J	150	$^{\circ}C$
存储温度 Storage Temperature	T_{Stg}	-55...+150	$^{\circ}C$

① 超过最大额定值表中列出的使用条件可能会损坏芯片。如果超过这些限制值中的任何一个，则芯片的功能可能无法保证，芯片可能发生损坏并影响可靠性。

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

热阻特性 Thermal Resistance^②

参数 Parameter	符号 Symbol	数值 (最大) Max. Value	单位 Unit
结到环境热阻 Thermal Resistance Junction to Ambient	$R_{\theta JA}$	250	$^{\circ}C/W$

② 芯片表面贴于 70mmX70mm 环氧树脂 PCB 板。

Surface mounted on Mounted on 70mmx70mm FR4 board

电气特性 Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

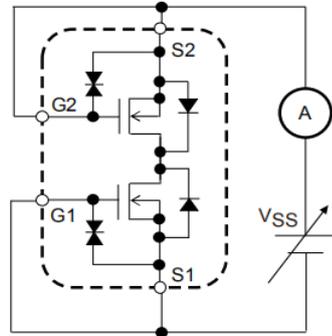
项目③ Parameter	符号 Symbol	测试条件 Conditions	数值 Value			单位 Unit
			Min.	Typ.	Max.	
漏极-漏极击穿电压 Source to Source Breakdown Voltage	$V_{(BR)SSS}$	$I_S = 1\text{ mA}, V_{GS} = 0\text{ V}$ Test Circuit 1	12	-	-	V
零栅压下漏极漏电流 Zero Gate Voltage Source Current	I_{SSS}	$V_{SS} = 10\text{ V}, V_{GS} = 0\text{ V}$ Test Circuit 1	-	-	1.0	μA
栅极-漏极漏电流 Gate to Source Leakage Current	I_{GSS1}	$V_{GS} = \pm 5\text{ V}, V_{SS} = 0\text{ V}$ Test Circuit 2	-	-	± 1.5	μA
栅极-漏极漏电流 Gate to Source Leakage Current	I_{GSS2}	$V_{GS} = \pm 8\text{ V}, V_{SS} = 0\text{ V}$ Test Circuit 2	-	-	± 10	μA
阈值电压 Gate Threshold Voltage	$V_{GS(th)}$	$V_{SS} = 6\text{ V}, I_S = 1\text{ mA}$ Test Circuit 3	0.4	-	1.0	V
漏极到漏极直流导通电阻 Static Source to Source On-State Resistance	$R_{SS(on)}$	$I_S = 5\text{ A}, V_{GS} = 4.5\text{ V}$ Test Circuit 4	3.3	5.5	6.9	$\text{m}\Omega$
		$I_S = 5\text{ A}, V_{GS} = 3.8\text{ V}$ Test Circuit 4	4.5	7.0	8.5	$\text{m}\Omega$
		$I_S = 5\text{ A}, V_{GS} = 3.1\text{ V}$ Test Circuit 4	5.0	7.5	9.0	$\text{m}\Omega$
		$I_S = 5\text{ A}, V_{GS} = 2.5\text{ V}$ Test Circuit 4	6.0	9.0	11.0	$\text{m}\Omega$
栅极电荷总量 Total Gate Charge	Q_g	$V_{SS} = 6\text{ V}, V_{GS} = 4.5\text{ V}, I_S = 5\text{ A}$ Test Circuit 6	-	13.5	-	nC
栅极电阻 Gate Resistance	R_g	$f = 1\text{ MHz}$		890		Ω
输入电容 Input Capacitance	C_{iss}	$V_{SS} = 6\text{ V}, V_{GS} = 0\text{ V},$ $f = 1\text{ kHz}$ $V_{GS2} = 6\text{ V}$		830		pF
输出电容 Output Capacitance	C_{oss}			750		pF
反向传输电容 Reverse Transfer Capacitance	C_{rss}			255		pF
漏极到漏极正向压降 Forward Source to Source Voltage	$V_{F(S-S)}$	$I_S = 1\text{ A}, V_{GS} = 0$ Test Circuit 7	0.4	0.7	1.0	V

③ 产品的参数性能按照上述表格参数所描述，除非有额外的说明。如果产品工作在其他不同的条件下，产品的电学性能可能并不遵守上述参数。

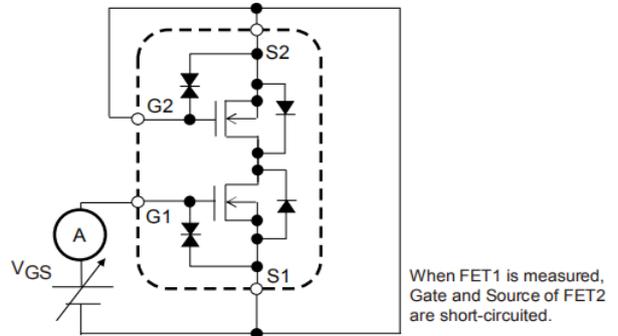
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

测试电路范例 Test Circuits Example

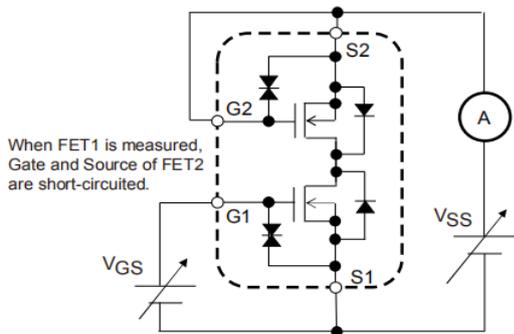
Test Circuit 1
V_{SS} / I_{SS}



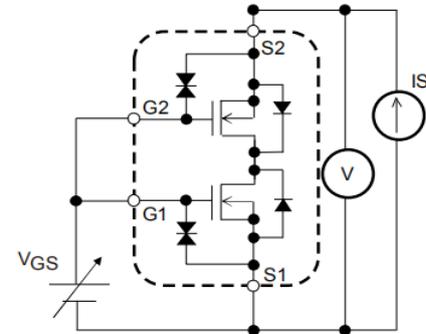
Test Circuit 2
I_{GSS}



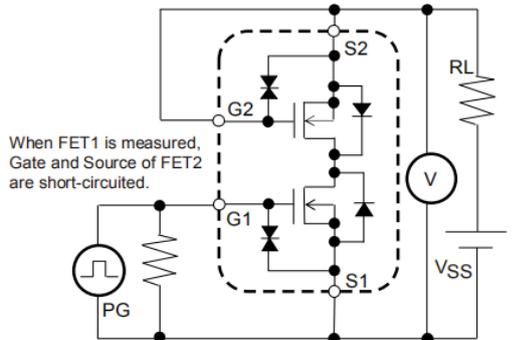
Test Circuit 3
V_{GS(th)}



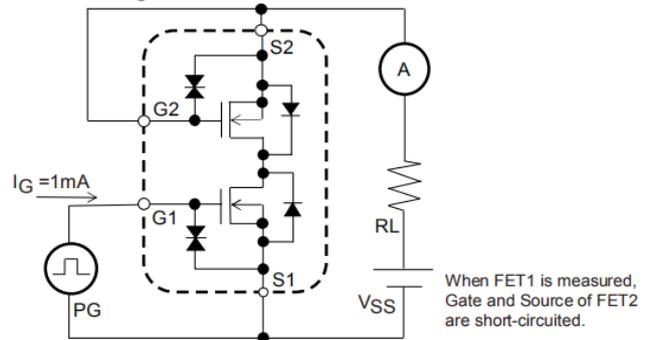
Test Circuit 4
R_{SS(on)}



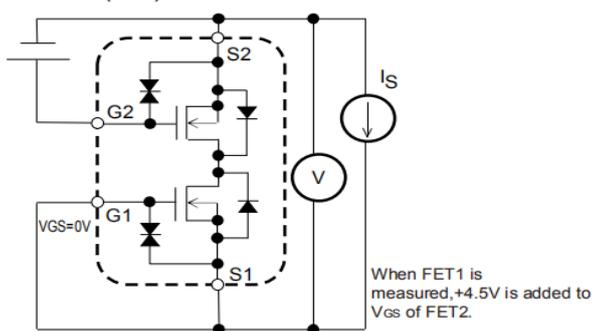
Test Circuit 5
t_{d(on)}, t_r, t_{d(off)}, t_f



Test Circuit 6
Q_g



Test Circuit 7
V_{F(S-S)}



特征电学和温度曲线 Typical Electrical and Thermal Characteristics

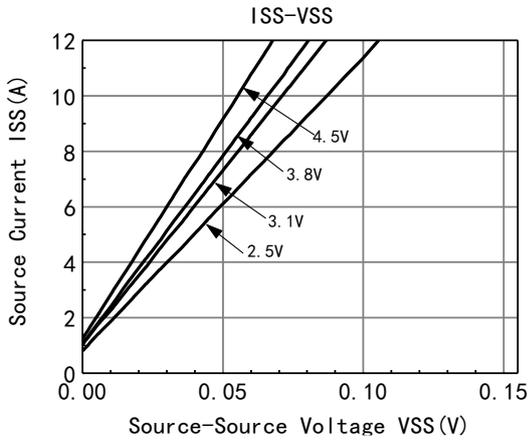


Figure 1: On-Region Characteristics

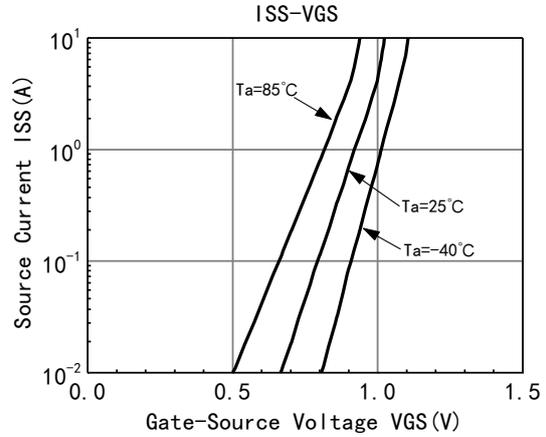


Figure 2: Typical Transfer Characteristics

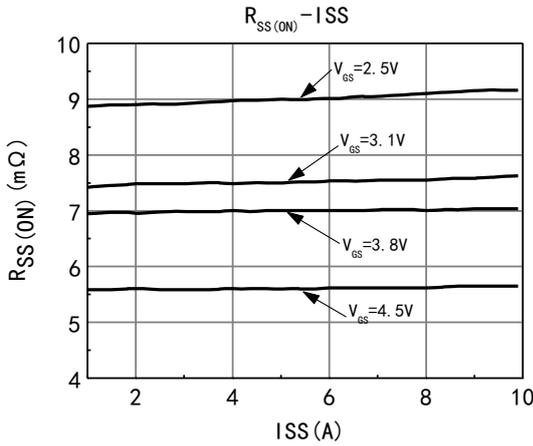


Figure 3: On-Resistance vs. Source Current and Gate Voltage

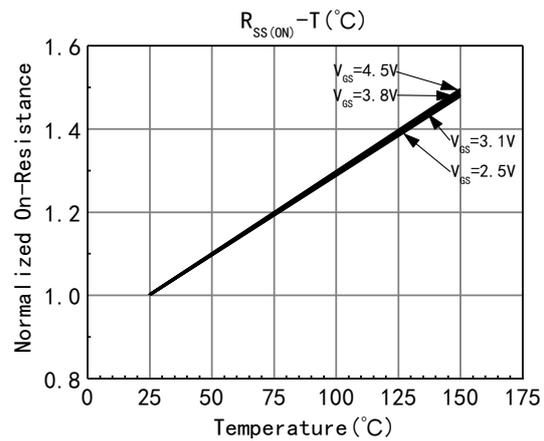


Figure 4: On-Resistance vs. Junction Temperature

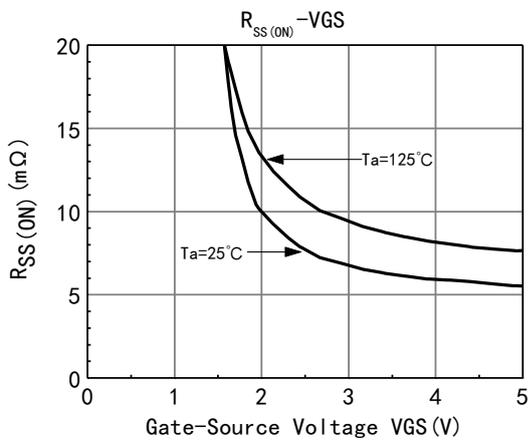


Figure 5: On-Resistance vs. Gate- Source Voltage

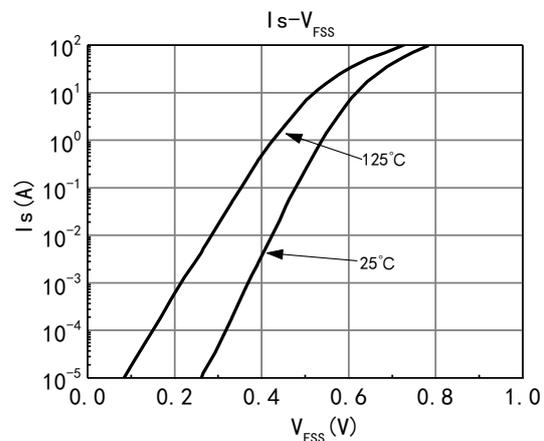


Figure 6: Forward Source to Source Characteristics

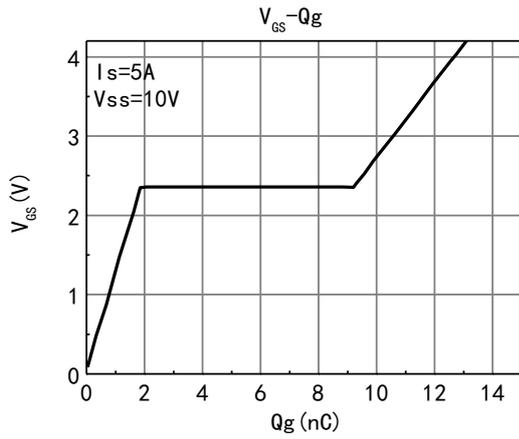


Figure 7: Gate-Charge Characteristics

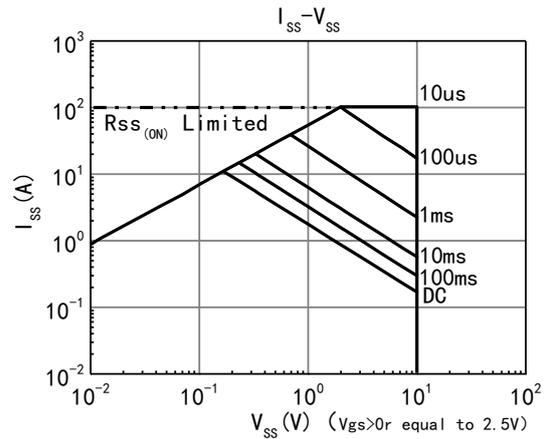


Figure 8: Safe Operating Area

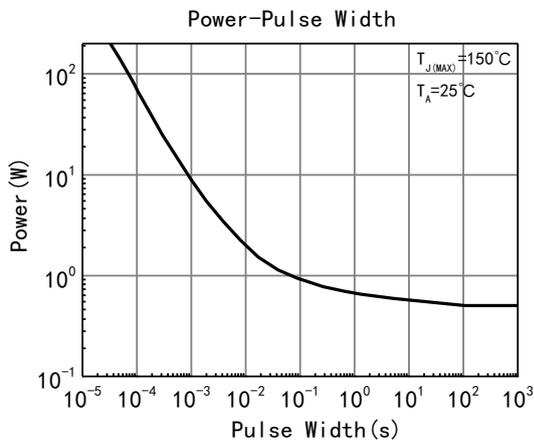


Figure 9: Single Pulse Power Rating Junction to Ambient

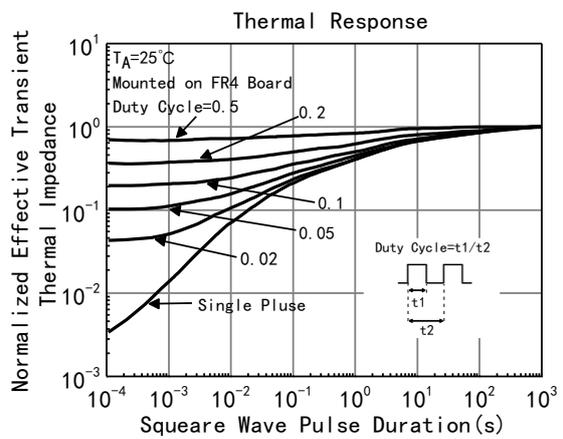


Figure 10: Normalized Maximum Transient Thermal Impedance

历史版本 Version history

版本号	时间	修改内容
Rev 1.0	2021 年 07 月	初始版本